

WHAT IS CLAIMED IS:

1. A content addressable memory cell comprising:
a first bit line for supplying a first bit;
a first storage element of a first phase change resistor for storing a first stored bit,
5 connected in series with a first diode; said first storage element connected to said first bit line;
a second bit line for supplying a second bit, said second bit being an inverse of said first
bit;
a second storage element of a second phase change resistor for storing a second stored
bit, connected in series with a second diode; said second storage element connected to said
10 second bit line; and
a match line connected to said first and second storage elements for indicating whether a
match occurred between said first bit and said first stored bit, and between said second bit and
said second stored bit.
2. The cell of claim 1 wherein each of said first and second phase change resistor is made of
15 chalcogenide material.
3. The cell of claim 2 wherein each cell is capable of storing one of three possible states:
a first state representing a data bit of "1" wherein the first stored bit represents a bit "1"
and the second stored bit represents a bit "0";
a second state representing a data bit of "0" wherein the first stored bit represents a bit
20 "0" and the second stored bit represents a bit "1";
a third state representing a "don't care" state wherein the first stored bit represents a bit
"0" and the second stored bit represents a bit "0".
4. The cell of claim 1 wherein said first diode connects said first phase change resistor to
said match line; and
25 wherein said second diode connects said second phase change resistor to said match line.
5. The cell of claim 1 wherein said first diode connects said first phase change resistor to
said first bit line; and

wherein said second diode connects said second phase change resistor to said second bit line.

6. An array of content addressable memory cells comprising:

a plurality of content addressable memory cells arranged in a plurality of rows and
5 columns;

a plurality of pairs of bit lines arranged in columns; each pair of bit lines for supplying a first bit and a second bit with said second bit being an inverse of said first bit; a pair of bit lines being supplied to the cells arranged in the same column;

a plurality of match lines, wherein each match line is connected to the cells arranged in
10 the same row; and

wherein each cell comprises:

a first storage element of a first phase change resistor for storing a first stored bit, connected in series with a first diode;

a second storage element of a second phase change resistor for storing a second
15 stored bit, connected in series with a second diode;

wherein the first storage element is connected to an associated match line and to one of a pair of associated bit lines; and

wherein each of the second storage element is connected to said associated match line and to another of said pair of associated bit lines.

20 7. The cell of claim 6 wherein each of said first and second phase change resistors is made of chalcogenide material.

8. The cell of claim 7 wherein each cell is capable of storing one of three possible states:

a first state representing a data bit of "1" wherein the first stored bit represents a bit "1" and the second stored bit represents a bit "0";

25 a second state representing a data bit of "0" wherein the first stored bit represents a bit "0" and the second stored bit represents a bit "1";

a third state representing a "don't care" state wherein the first stored bit represents a bit "0" and the second stored bit represents a bit "0".

9. The array of claim 6 wherein said first diode connects said first phase change resistor to an associated match line; and

wherein said second diode connects said second phase change resistor to said associated match line.

5 10. The array of claim 6 wherein said first diode connects said first phase change resistor to one of a pair of associated bit lines; and

wherein said second diode connects said second phase change resistor to another of said pair of associated bit lines.

10